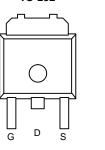
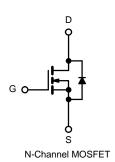


## N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Max.	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
	0.0055 at V <sub>GS</sub> = 10 V	75 <sup>a</sup>				
80	0.0088 at V <sub>GS</sub> = 6.0 V	65 <sup>a</sup>	17.1 nC			
	0.0115 at V <sub>GS</sub> = 5.0 V	54				

#### TO-252





Top View

#### **FEATURES**

- TrenchFET<sup>®</sup> Power MOSFET
- 100 %  $\rm R_g$  and UIS Tested

#### **APPLICATIONS**

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_A = 25 \text{ °C}$ , unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	80	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	v		
	T <sub>C</sub> = 25 °C		75 <sup>a</sup>		
Continuous Drain Current ( $T_{,1} = 150 \ ^{\circ}C$ )	T <sub>C</sub> = 70 °C		62.7		
Continuous Drain Current $(I_J = 150 \text{ C})$	T <sub>A</sub> = 25 °C	I <sub>D</sub>	28.6 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		24.9 <sup>b, c</sup>	А	
Pulsed Drain Current (t = 100 μs)		I <sub>DM</sub>	150		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		75a		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	4.5 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	30		
Single Pulse Avalanche Energy		E <sub>AS</sub>	45	mJ	
	T <sub>C</sub> = 25 °C		62.5		
Maximum Dawar Dissinction	T <sub>C</sub> = 70 °C		40	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	5 <sup>b, c</sup>	vv	
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ran	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature)		260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
$Maximum Junction-to-Ambient^{b, f}    t \le 10 s$		R <sub>thJA</sub>	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	1.5	2.0	0/00	

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

- d. The TO-220 is a leadless package. The end of the lead terminal is exposed
- copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 70 °C/W.

## **SUD40N08**

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	www	v.VBsemi.tw	

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	80			V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			37		m\//°C		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 6.1		mV/°C		
Gate-Source Threshold Voltage	V <sub>GS(th</sub> )	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.5		4.0	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA		
		V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V			1	μA		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 V, V_{GS} = 10 V$	30			Α		
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0050				
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 6 V, I <sub>D</sub> = 15 A		0.0070		Ω		
		$V_{GS} = 5.0 \text{ V}, \text{ I}_{D} = 10 \text{ A}$		0.0087				
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 20 A		60		S		
Dynamic <sup>b</sup>	•			•		•		
Input Capacitance	C <sub>iss</sub>			1855				
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz		950		рF		
Reverse Transfer Capacitance	C <sub>rss</sub>			76				
	Q <sub>g</sub> Q <sub>gs</sub>	$V_{DS} = 40 V, V_{GS} = 10 V, I_{D} = 10 A$		35.5	54	-		
Total Gate Charge		$V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		22	33			
				17.1	26	nC		
Gate-Source Charge		$V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		5.3				
Gate-Drain Charge	Q <sub>gd</sub>			7.3				
Output Charge	Q <sub>oss</sub>	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		57	86			
Gate Resistance	Rg	f = 1 MHz	0.5	1.3	2	Ω		
Turn-On Delay Time	t <sub>d(on)</sub>			12	24	-		
Rise Time	t <sub>r</sub>	$V_{DD} = 40 \text{ V}, \text{ R}_{1} = 4 \Omega$		8	16			
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong 10$ Å, $V_{GEN} = 10$ V, $R_g = 1$ $\Omega$		32	64			
Fall Time	t <sub>f</sub>			7	14			
Turn-On Delay Time	t <sub>d(on)</sub>			14	28	ns		
Rise Time				11	22			
Turn-Off DelayTime	t <sub>d(off)</sub>	$\label{eq:VDD} \begin{array}{l} V_{\text{DD}} = 40 \text{ V}, \ R_{\text{L}} = 4 \ \Omega \\ I_{\text{D}} \cong \ 10 \ \text{A}, \ V_{\text{GEN}} = 6.0 \ \text{V}, \ R_{\text{g}} = 1 \ \Omega \end{array}$		30	60			
Fall Time	t <sub>f</sub>			8	16			
Drain-Source Body Diode Characteristic	Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			75	^		
Pulse Diode Forward Current (t = $100 \ \mu s$ )	I <sub>SM</sub>				150	A		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.76	1.1	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			38	75	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			36	70	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		19		20		
Reverse Recovery Rise Time t <sub>b</sub>				19		ns		

#### Notes

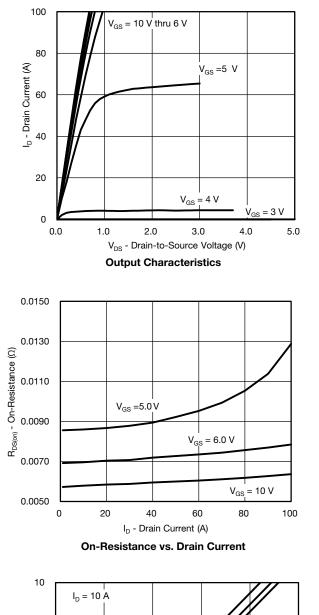
a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

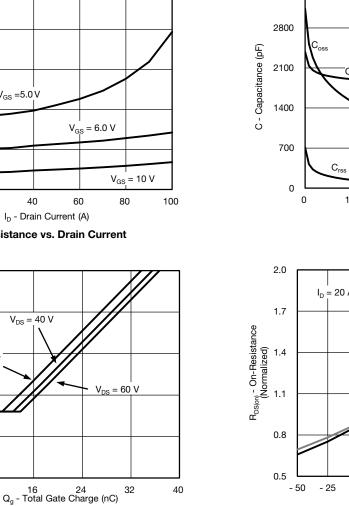
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

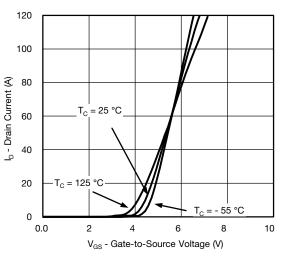
### **SUD40N08**



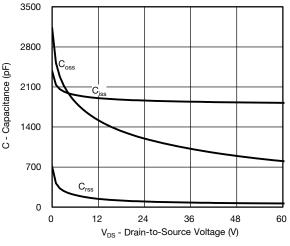


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

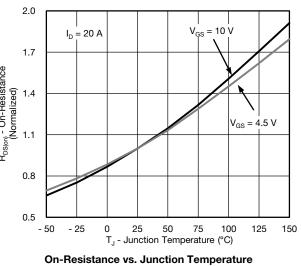




Transfer Characteristics







V<sub>GS</sub> - Gate-to-Source Voltage (V)

8

6

4

2

0

0

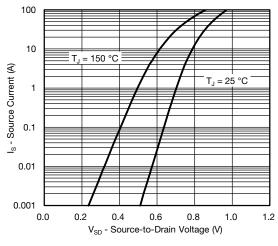
 $V_{DS} = 20 V$ 

8

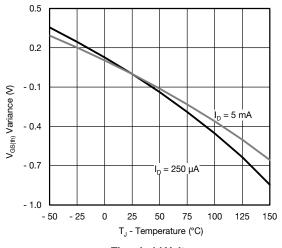
**Gate Charge** 



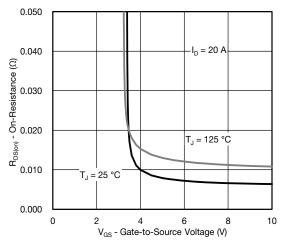
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



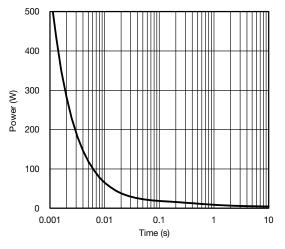
Source-Drain Diode Forward Voltage



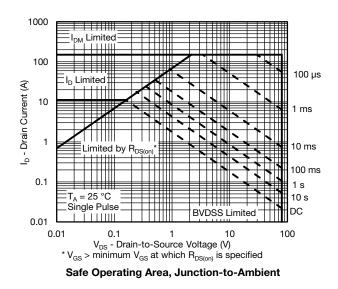
Threshold Voltage



**On-Resistance vs. Gate-to-Source Voltage** 

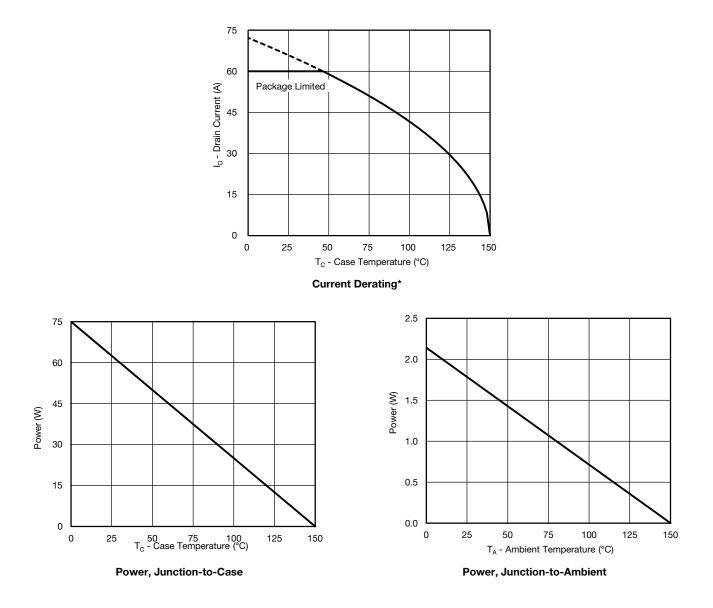


Single Pulse Power, Junction-to-Ambient





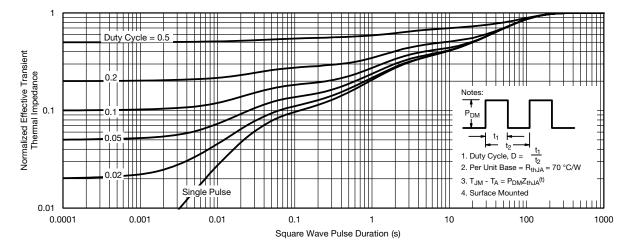
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



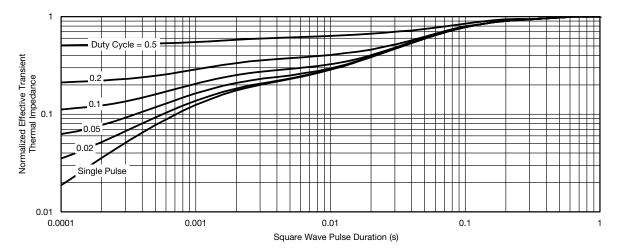
\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



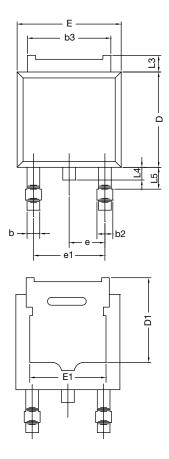
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-252AA CASE OUTLINE**





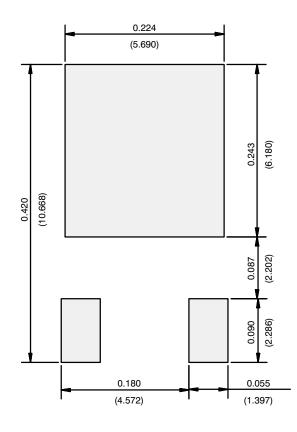
	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
E	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	e 2.28 BSC 0.090 BSC				
e1	4.56	BSC	0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

#### Note

• Dimension L3 is for reference only.



#### **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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